

MOSFET - Power, Single N-Channel 40 V, 5 mΩ, 68 A NVLJWS6D0N04CL

Features

- Small Footprint for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Parameter | | | Symbol | Value | Unit |
|---|------------------------|----------------------------|-----------------------------------|----------------|------|
| Drain-to-Source Voltage | | | V_{DSS} | 40 | ٧ |
| Gate-to-Source Voltage | Gate-to-Source Voltage | | | ±20 | ٧ |
| Continuous Drain | Steady State | T _C = 25°C | I _D | 68 | Α |
| Current R _{θJC} (Notes 1, 3) | | T _C = 100°C | | 48 | |
| Power Dissipation | | T _C = 25°C | P_{D} | 46 | W |
| R _{θJC} (Note 1) | | T _C = 100°C | | 23 | |
| Continuous Drain | Steady State | T _A = 25°C | I _D | 15 | Α |
| Current R _{θJA} (Notes 1, 2, 3) | | T _A = 100°C | | 11 | |
| Power Dissipation | | T _A = 25°C | P_{D} | 2.5 | W |
| R _{θJA} (Notes 1, 2) | | T _A = 100°C | | 1.2 | |
| Pulsed Drain Current | $T_A = 25$ | °C, t _p = 10 μs | I _{DM} | 277 | Α |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +175 | °C |
| Source Current (Body Diode) | | | Is | 38 | Α |
| Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 4 A) | | | E _{AS} | 113 | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | TL | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

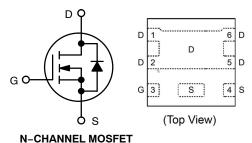
THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case - Steady State | $R_{\theta JC}$ | 3.3 | °C/W |
| Junction-to-Ambient - Steady State (Note 2) | $R_{\theta JA}$ | 61 | |

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX | |
|----------------------|-------------------------|--------------------|--|
| 40 V | 5 mΩ @ 10 V | 68 A | |
| | 8 mΩ @ 4.5 V | 00 / | |

ELECTRICAL CONNECTION





WDFNW6 (2.05x2.05) CASE 515AD

MARKING DIAGRAM



XXXX = Specific Device Code A = Assembly Location

L = Wafer Lot
Y = Year
W = Work Week

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit | |
|--|-------------------------------------|--|-------------------------|-----|------|-----|-------|--|
| OFF CHARACTERISTICS | | | | | | | | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | | 40 | | | V | |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} / | | | | 21 | | mV/°C | |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, | T _J = 25 °C | | | 10 | | |
| | | $V_{DS} = 40 \text{ V}$ | T _J = 125°C | | | 100 | μΑ | |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _G | _S = 20 V | | | 100 | nA | |
| ON CHARACTERISTICS (Note 4) | | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_{D}$ | = 34 μΑ | 1.2 | | 2.0 | V | |
| Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | -5.3 | | mV/°C | |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 10 A | | 4 | 5 | | |
| | | V _{GS} = 4.5 V | I _D = 10 A | | 6 | 8 | mΩ | |
| Forward Transconductance | 9 _F s | V _{DS} =3 V, I _D | = 10 A | | 38 | | S | |
| CHARGES AND CAPACITANCES | | | | | | | • | |
| Input Capacitance | C _{ISS} | | | | 1150 | | | |
| Output Capacitance | Coss | V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V | | | 475 | | pF | |
| Reverse Transfer Capacitance | C _{RSS} | | | | 18 | | | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 4.5 V, V _{DS} = 32 V; I _D = 10 A | | | 10 | | nC | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 10 V, V _{DS} = 32 V; I _D = 10 A | | | 20 | | nC | |
| Threshold Gate Charge | Q _{G(TH)} | | | | 1.7 | | | |
| Gate-to-Source Charge | Q _{GS} | | | | 3.1 | | nC | |
| Gate-to-Drain Charge | Q _{GD} | | | | 3.0 | | 1 | |
| Plateau Voltage | V _{GP} | | | | 2.6 | | V | |
| SWITCHING CHARACTERISTICS (Note: | 5) | | | | | | | |
| Turn-On Delay Time | t _{d(ON)} | | | | 9 | | | |
| Rise Time | t _r | V _{GS} = 10 V, V _I | os = 32 V, | | 5 | | ns | |
| Turn-Off Delay Time | t _{d(OFF)} | $V_{GS} = 10 \text{ V}, V_{E}$ $I_{D} = 10 \text{ A}, R_{e}$ | $_{\rm G}$ = 6 Ω | | 31 | | | |
| Fall Time | t _f | <u>'</u> | | | 7 | | 1 | |
| DRAIN-SOURCE DIODE CHARACTERIS | STICS | | | | | | | |
| Forward Diode Voltage | V _{SD} | V _{GS} = 0 V, | T _J = 25°C | | 0.79 | 1.2 | | |
| | | $I_S = 10 \text{ A}$ | T _J = 125°C | | 0.65 | | V | |
| Reverse Recovery Time | t _{RR} | $V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 10 \text{ A}$ | | | 33 | | ns | |
| Charge Time | ta | | | | 15 | | | |
| Discharge Time | t _b | | | | 18 | |] | |
| Reverse Recovery Charge | Q _{RR} | | | | 15 | | nC | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

 $R_{DS(on)},\,DRAIN-TO-SOURCE\,RESISTANCE\,(m\Omega)$

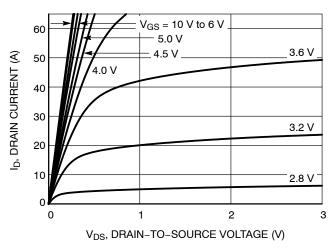


Figure 1. On-Region Characteristics

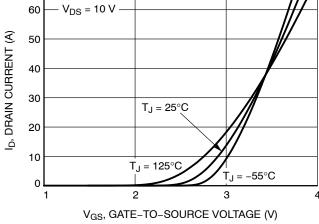


Figure 2. Transfer Characteristics

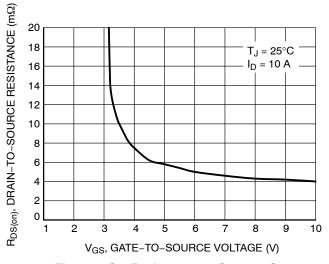


Figure 3. On-Resistance vs. Gate-to-Source Voltage

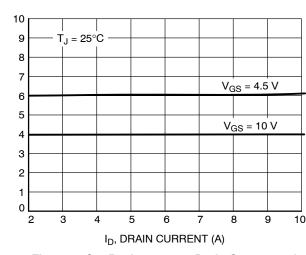


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

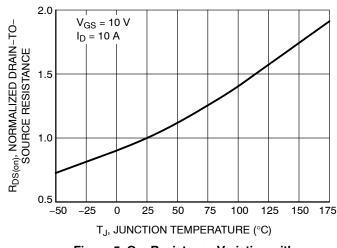


Figure 5. On–Resistance Variation with Temperature

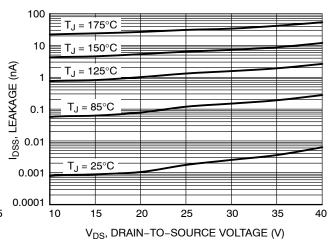
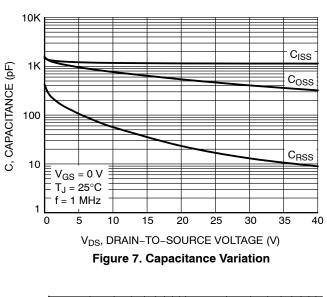


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS



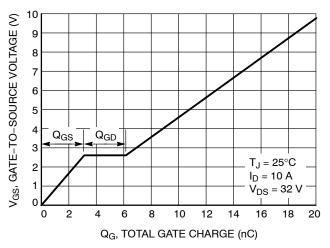
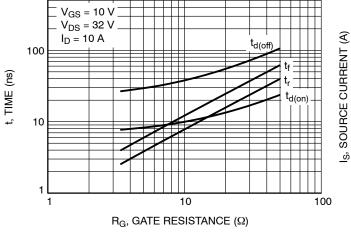


Figure 8. Gate-to-Source Voltage vs. Total Charge



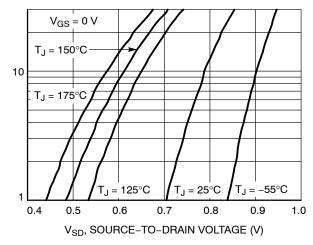
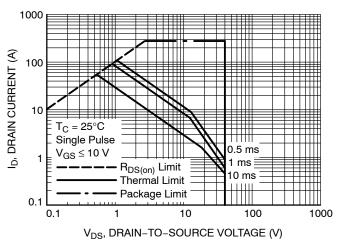


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



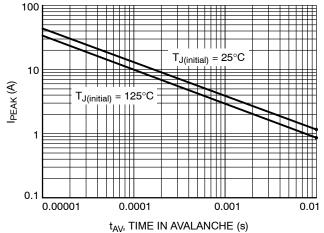


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

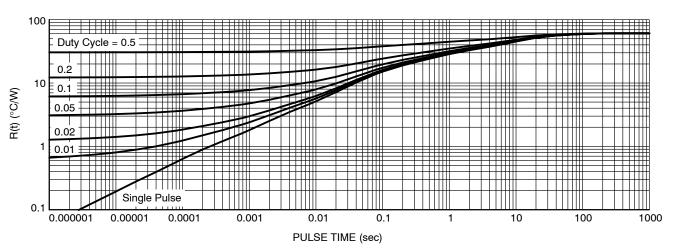


Figure 13. Transient Thermal Impedance

DEVICE ORDERING INFORMATION

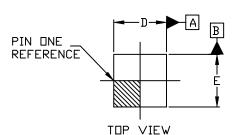
| Device | Marking | Package | Shipping [†] |
|-------------------|---------|--------------------------------------|-----------------------|
| NVLJWS6D0N04CLTAG | 6D0N | WDFNW6 (Pb-Free, Wettable Flanks) | 3000 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

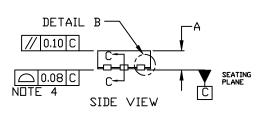
WDFNW6 2.05x2.05, 0.65P

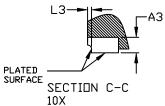
CASE 515AD **ISSUE O**

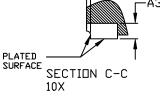


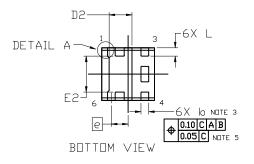
NOTES:

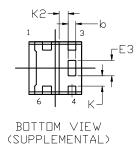
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1.
- CONTROLLING DIMENSION: MILLIMETERS
 DIMENSION & APPLIES TO PLATED TERMINALS AND IS
 MEASURED BETWEEN 0.15 AND 0.30MM FROM THE TERMINAL TIP.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- POSITIONAL TOLERANCE APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.



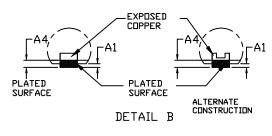


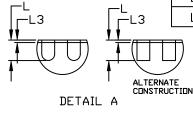


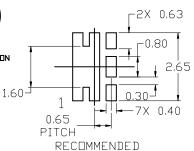




| | MILLIMETERS | | | |
|-----|-------------|----------|-------|--|
| DIM | MIN. | N□M. | MAX. | |
| Α | 0.70 | 0.75 | 0.80 | |
| A1 | 0.00 | | 0.05 | |
| A3 | ľ | 0.20 REF | - | |
| Α4 | 0.10 | | | |
| b | 0.25 | 0.30 | 0.35 | |
| D | 1.95 | 2.05 | 2.15 | |
| DS | 0.84 | 0.89 | 0.94 | |
| E | 1.95 | 2.05 | 2,15 | |
| E2 | 1.35 | 1.40 | 1,45 | |
| E3 | 0.55 | 0.60 | 0.65 | |
| e | 0.65 BSC | | | |
| K | 0.40 REF | | | |
| К2 | 0.35 REF | | | |
| L | 0.275 | 0.325 | 0.375 | |
| L3 | | | 0.09 | |







MOUNTING FOOTPRINT For additional information on our Pb-Free strategy and soldering details, please download the DN Seniconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

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